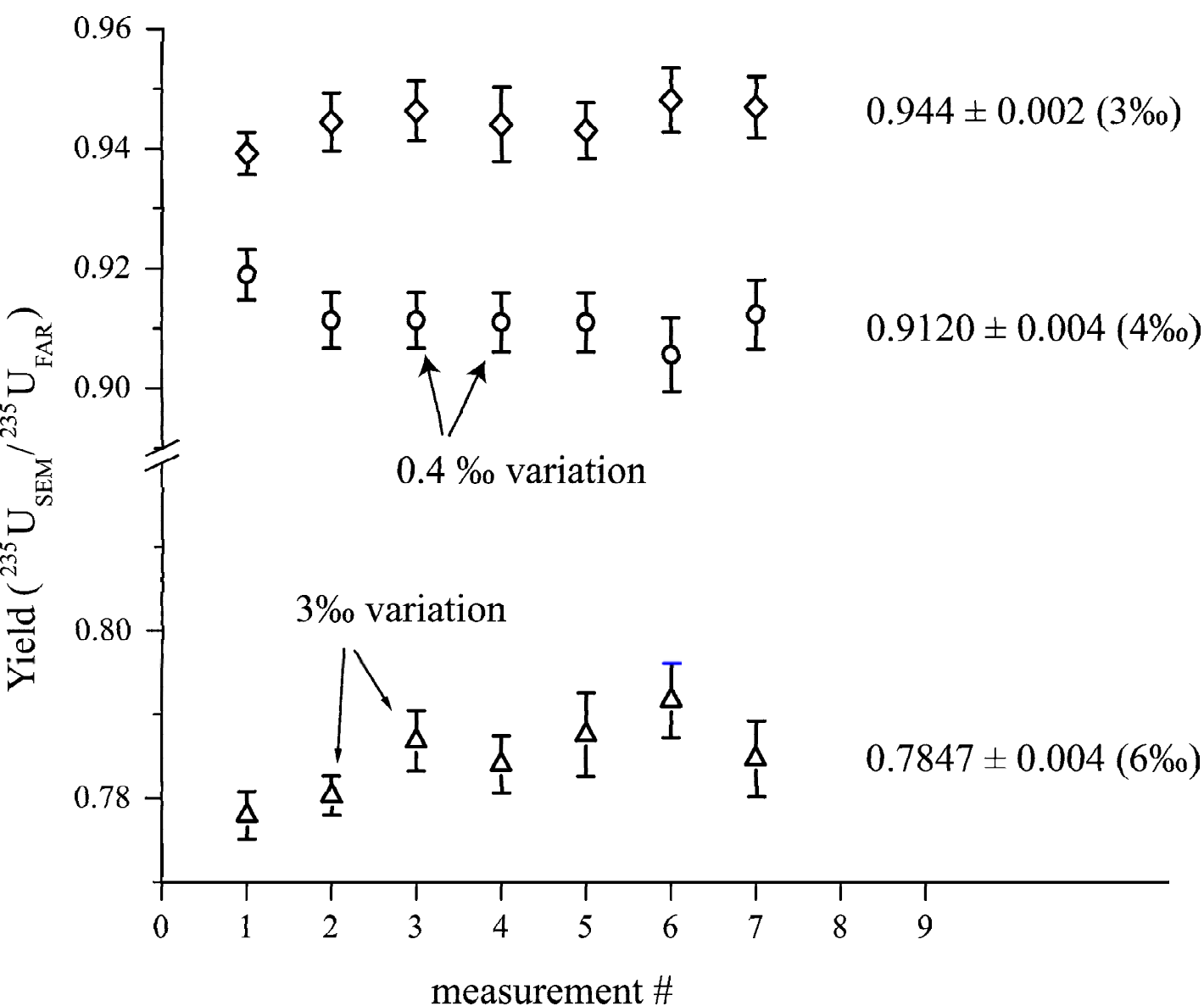


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Fig.S1



Stability of the calculated ^{235}U SEM/FAR yield for three different sessions. Data corresponds to ion beam intensities ranging between 0.3 and 0.6 V. Arrows indicate maximum and minimum variability.